

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/624,511 CEREDA ET AL.	
		Examiner	Art Unit	Page 1 of 1 Feben M. Haile 2616

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*	B	US-6,472,951	10-2002	Fiedziuszko et al.	333/126
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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